

Search Notes

Application/Control No.

10/790,720

Examiner

Shin-Lin Chen

Applicant(s)/Patent under
Reexamination

WU ET AL.

Art Unit

1632

SEARCHED

Class	Subclass	Date	Examiner
800	4		
800	13		
800	17		
800	21		
800	22		
800	25		
435	320.1		
536	23.5	3/13/2006	<i>SLC</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
800	4		
800	13		
800	17		
800/21, 22, 25, 435/320.1, 536/23.5, AU interference search		3/13/2006	<i>SLC</i>

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated.	3/13/2006	<i>SLC</i>